CRMPGL0604A

N-Channel 60V, 4.7mΩ Typ. Power MOSFET

Description

Features

• 60V, 20A

$$R_{DS(ON)}$$
 Typ = 4.7m Ω @ V_{GS} = 10V

$$R_{DS(ON)}$$
 Typ = 5.8m Ω @ V_{GS} = 4.5V

- Advanced Split Gate Trench Technology
- Excellent R_{DS(ON)} and Low Gate Charge
- Lead Free
- 100% UIS TESTED!

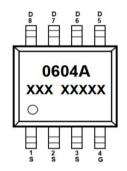
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Application

- Load Switch
- PWM Application
- Power Management





Marking and Pin Assignment

Package Marking and Ordering Information

| Device | Marking | Package | Outline | Reel Size | Reel (pcs) | Per Carton (pcs) |
|-------------|---------|---------|---------|-----------|------------|------------------|
| CRMPGL0604A | 0604A | SOP-8 | TAPING | 13" | 4000 | 40000 |

Absolute Maximum Ratings (@ T_J = 25°C unless otherwise specified)

| Symbol | Parameter | | Value | Units |
|-----------------|--|------------------------|------------|-------|
| V_{DS} | Drain-to-Source Voltage | | 60 | V |
| V_{GS} | Gate-to-Source Voltage | | ±20 | V |
| | Continuous Drain Current | T _A = 25°C | 20 | А |
| I _D | -Continuous Diain Current | T _A = 100°C | 12 | Α |
| I _{DM} | Pulsed Drain Current ⁽¹⁾ | | 80 | Α |
| E _{AS} | Single Pulsed Avalanche Energy (2) | | 110 | mJ |
| P_{D} | Power Dissipation | T _A = 25°C | 4.2 | W |
| $R_{	heta JA}$ | Thermal Resistance, Junction to Ambier | nt ⁽³⁾ | 30 | °C/W |
| T_J,T_STG | Junction & Storage Temperature Range | | -55 to 150 | °C |



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Electrical Characteristics (T_J = 25°C unless otherwise specified)

| Symbol | Parameter | Conditions | Min. | Тур. | Max. | Uni |
|----------------------|--|---|--------------|------|------|-----|
| Off Chara | acteristics | | | | | |
| V _{(BR)DSS} | Drain-Source Breakdown Voltage | $I_D = 250 \mu A, V_{GS} = 0 V$ | 60 | - | - | V |
| I _{DSS} | Zero Gate Voltage Drain Current | $V_{DS} = 60V, V_{GS} = 0V$ | - | - | 1.0 | μΑ |
| I _{GSS} | Gate-Body Leakage Current | $V_{DS} = 0V, V_{GS} = \pm 20V$ | - | - | ±100 | nA |
| On Chara | acteristics | | | | 6 | |
| $V_{GS(th)}$ | Gate Threshold Voltage | $V_{DS} = V_{GS}, I_{D} = 250 \mu A$ | 1.2 | 1.6 | 2.5 | V |
| R _{DS(ON)} | Static Drain-Source ON-Resistance ⁽⁴⁾ | $V_{GS} = 10V, I_D = 20A$ | - | 4.7 | 6.1 | mΩ |
| | | $V_{GS} = 4.5V, I_D = 10A$ | - | 5.8 | 7.5 | mΩ |
| Dynamic | Characteristics | | | | | |
| C _{iss} | Input Capacitance | | -(| 1960 | - | pF |
| C_{oss} | Output Capacitance | $V_{GS} = 0V, V_{DS} = 30V,$ f = 1MHz | X - \ | 650 | - | pF |
| C_{rss} | Reverse Transfer Capacitance | 1 - 11VII 12 | - | 29 | - | pF |
| Q_g | Total Gate Charge | | J - | 35 | - | nC |
| Q_gs | Gate Source Charge | $V_{GS} = 0 \text{ to } 10V$ $V_{DS} = 30V, I_{D} = 20A$ | - | 10 | - | nC |
| Q_{gd} | Gate Drain("Miller") Charge | VDS = 00 V, 1D = 20/1 | - | 7 | - | nC |
| Switchin | g Characteristics | | | | | |
| $t_{d(on)}$ | Turn-On DelayTime | .rO | - | 12 | - | ns |
| t _r | Turn-On Rise Time | $V_{GS} = 10V, V_{DD} = 30V$ | - | 34 | - | ns |
| $t_{\text{d(off)}}$ | Turn-Off DelayTime | I_{D} = 20A, R_{GEN} = 4.5 Ω | - | 25 | - | ns |
| t _f | Turn-Off Fall Time | > | | 30 | | ns |
| Drain-So | urce Diode Characteristics and M | Max Ratings | | | | |
| I _S | Maximum Continuous Drain to Source Diode Forward Current | | | - | 20 | А |
| I _{SM} | Maximum Pulsed Drain to Source Diode Forward Current | | - | - | 80 | А |
| V_{SD} | Drain to Source Diode Forward Voltage | $V_{GS} = 0V, I_{S} = 30A$ | - | - | 1.2 | V |
| trr | Body Diode Reverse Recovery Time | 1 - 20 A di/dt - 400 A /··- | - | 38 | - | ns |
| Qrr | Body Diode Reverse Recovery Charge | $I_F = 20A$, di/dt = 100A/us | _ | 23 | - | nC |

Notes:

^{1.} Repetitive Rating: Pulse Width Limited by Maximum Junction Temperature.

^{2.} E_{AS} condition: Starting T_J =25°C, V_{DD} =30V, V_G =10V, R_G =25ohm, L=0.5mH, I_{AS} =21A

^{3.} $R_{\scriptscriptstyle \theta JA}$ is measured with the device mounted on a 1inch² pad of 2oz copper FR4 PCB

^{4.} Pulse Test: Pulse Width≤300µs, Duty Cycle≤0.5%.

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Test Circuit

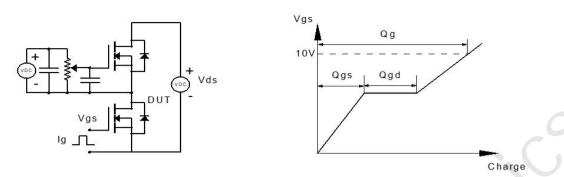


Figure 1: Gate Charge Test Circuit & Waveform

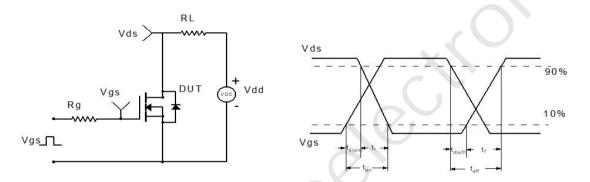


Figure 2: Resistive Switching Test Circuit & Waveform

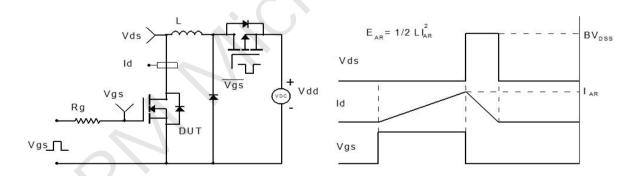


Figure 3: Unclamped Inductive Switching Test Circuit& Waveform

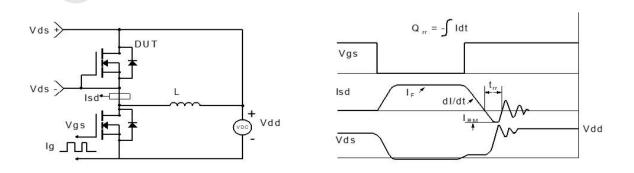
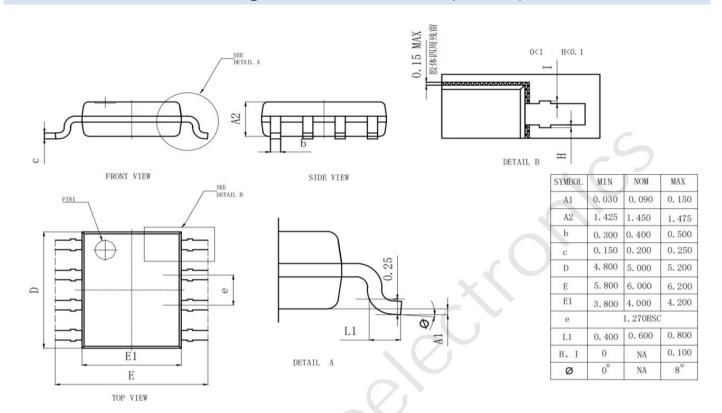


Figure 4: Diode Recovery Test Circuit & Waveform

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Package Mechanical Data(SOP-8)



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Contact information

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